

## P-Channel Enhancement Mode MOSFET

### GENERAL DESCRIPTION

The PW2319 uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

### FEATURES

VDS = -40V, ID = -5A

RDS(ON) < 70mΩ @ VGS=-10V

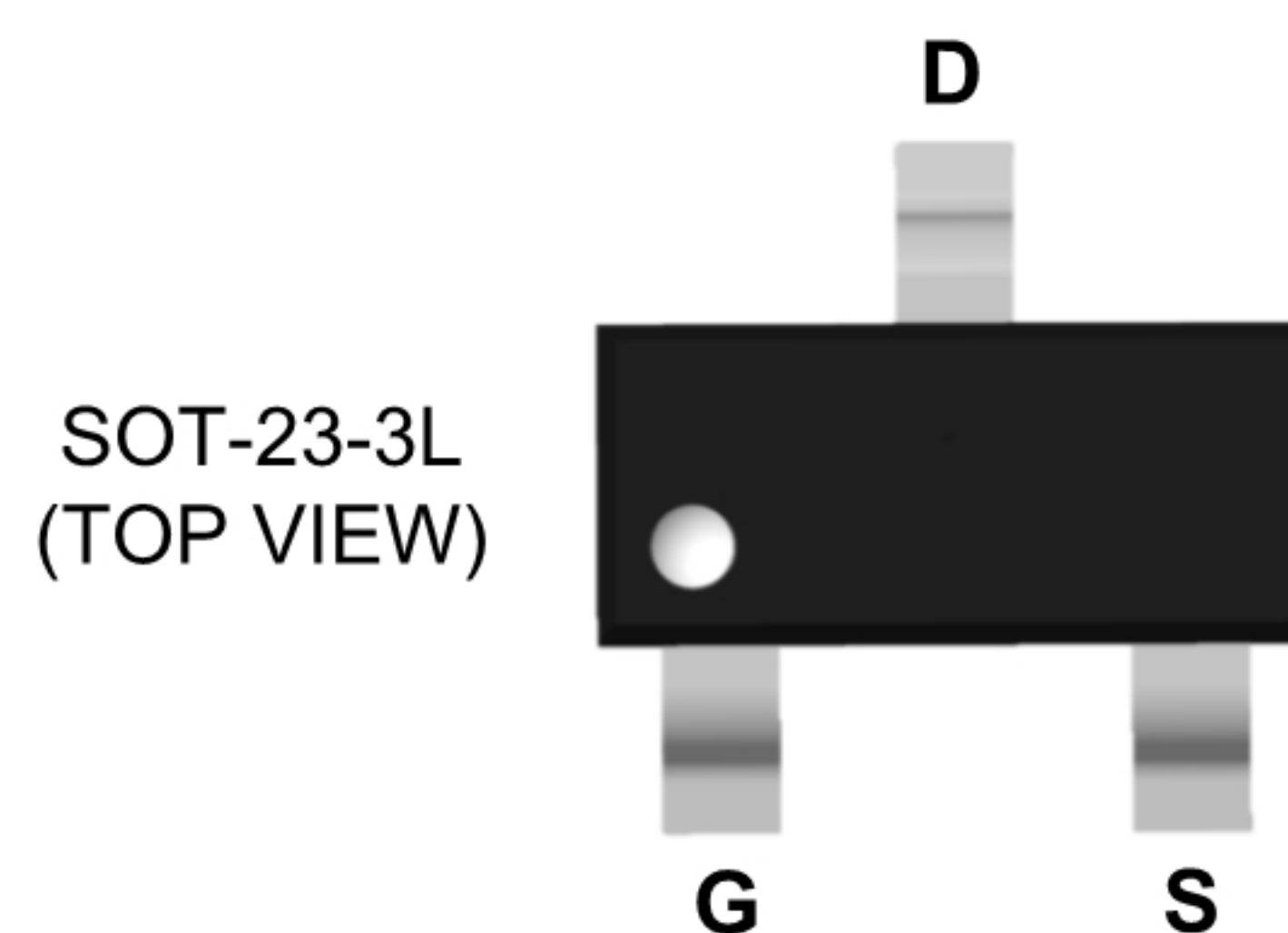
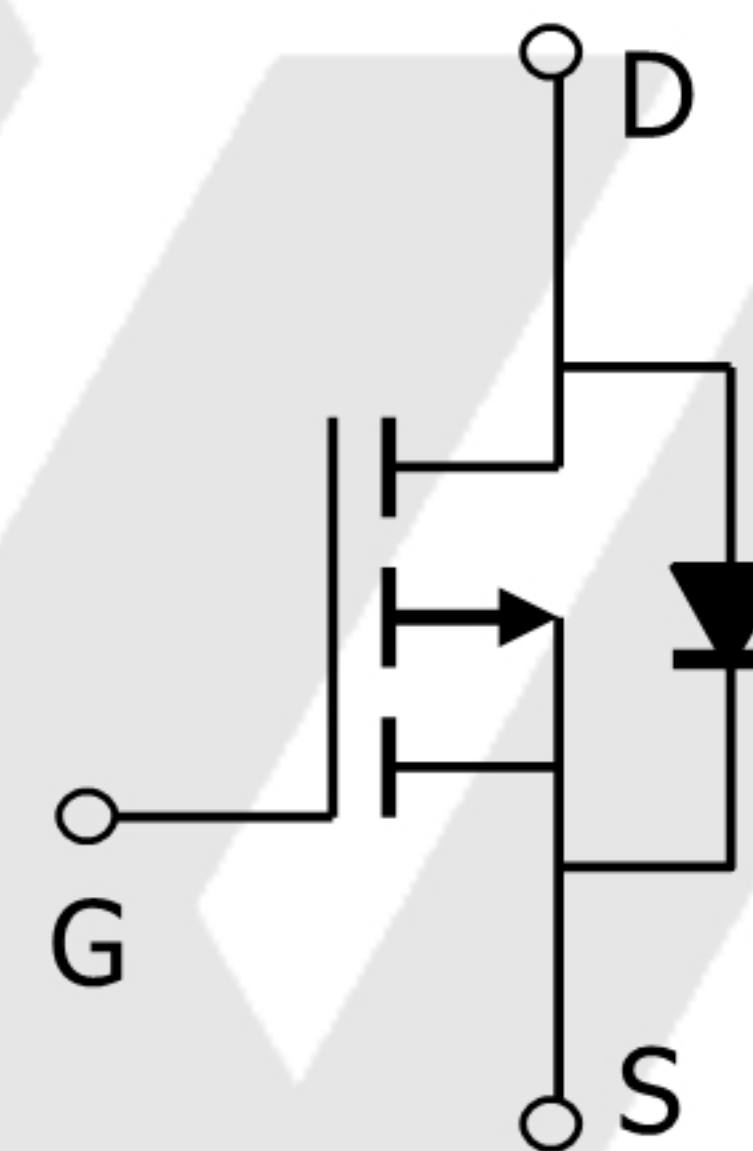
Available in a 3-Pin SOT23-3 Package

### Application

Battery protection

Load switch

Uninterruptible power suppl



### Absolute Maximum Ratings (TA=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	-40	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current, VGS @ -4.5V (NOTE1)	ID@TA=25°C	-3.2	A
	ID@TA=70°C	-2.6	A
Pulsed Drain Current (NOTE2)	IDM	-16.1	A
Total Power Dissipation (NOTE3)	P <sub>D</sub> @TA=25°C	1	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 To 150	°C
Thermal Resistance Junction-Ambient (NOTE1)	R <sub>θJA</sub>	125	°C/W
Thermal Resistance Junction-Ambient (t ≤ 10s) (NOTE1)	R <sub>θJA</sub>	95	°C/W
Thermal Resistance Junction-Case (NOTE1)	R <sub>θJC</sub>	80	°C/W

Note 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

Note 2.The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%

Note 3.The power dissipation is limited by 150°C junction temperature



## ELECTRICAL CHARACTERISTICS

(TA = 25°C, unless otherwise noted.)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA	-40			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =-1mA		-0.018		V/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance (NOTE2)	V <sub>GS</sub> =-2.5V , I <sub>D</sub> =-2A			100	mΩ
		V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-3A			70	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250uA	-1.0		-2.5	V
$\Delta V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient			2.5		mV/°C
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =-24V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			-1	uA
		V <sub>DS</sub> =-24V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			-5	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =-5V , I <sub>D</sub> =-3A		5.8		S
Q <sub>g</sub>	Total Gate Charge (-4.5V)	V <sub>DS</sub> =-32, V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-3		6.4		nC
Q <sub>gs</sub>	Gate-Source Charge			2.1		nC
Q <sub>gd</sub>	Gate-Drain Charge			2.5		nC
T <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DS</sub> =-20, V <sub>GS</sub> =-4.5 R <sub>G</sub> =3.3Ω, I <sub>D</sub> =-3		4.2		ns
T <sub>r</sub>	Rise Time			23		ns
T <sub>d(off)</sub>	Turn-Off Delay Time			26.8		ns
T <sub>f</sub>	Fall Time			20.6		ns
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		620		pF
C <sub>oss</sub>	Output Capacitance			65		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			53		pF
I <sub>S</sub>	Continuous Source Current(NOTE1, 3)	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-3.2	A
I <sub>SM</sub>	Pulsed Source Current(NOTE2, 3)				-16.1	A
V <sub>SD</sub>	Diode Forward Voltage (NOTE2)	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C			-1	V

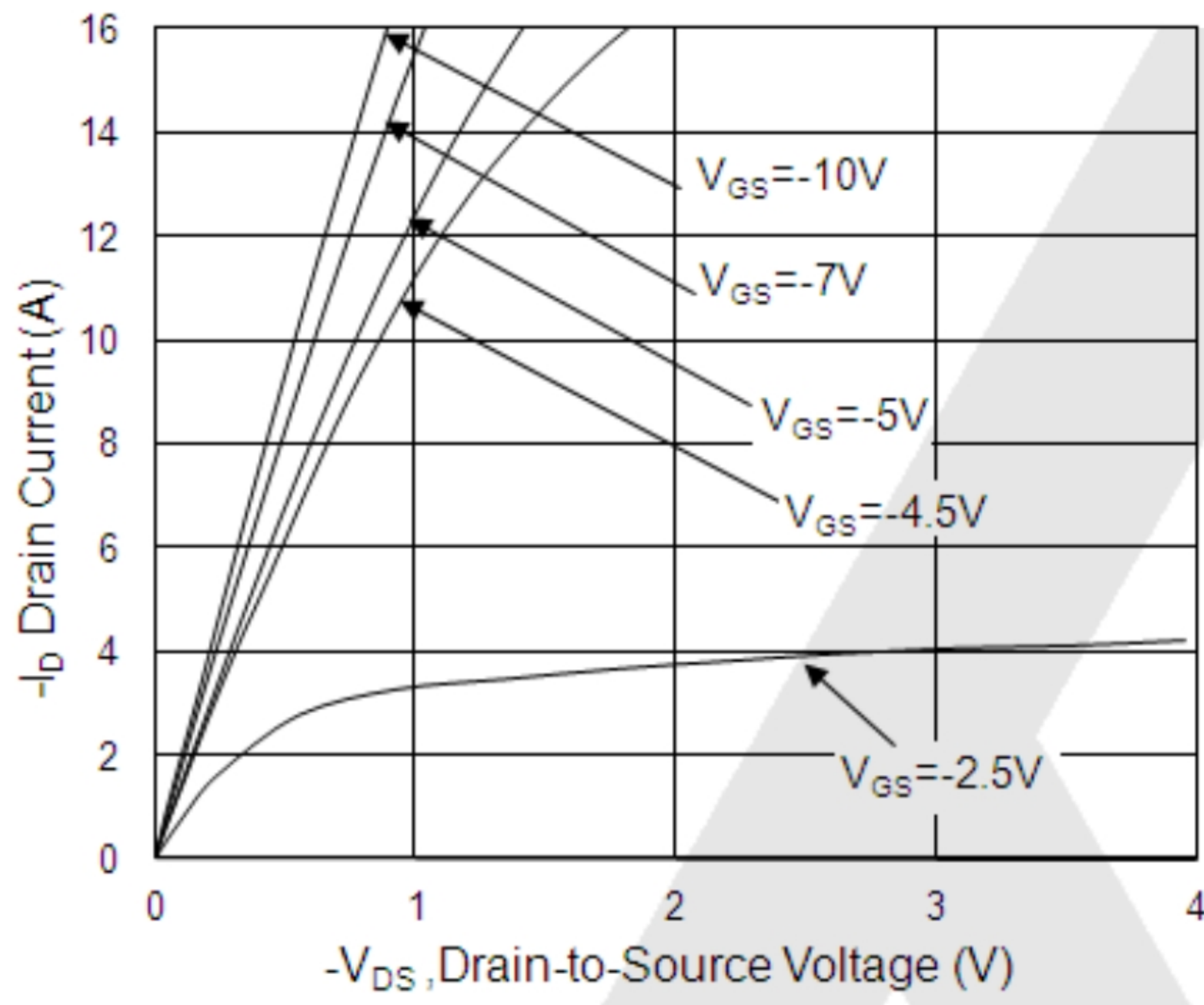
Note 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

Note 2.The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%

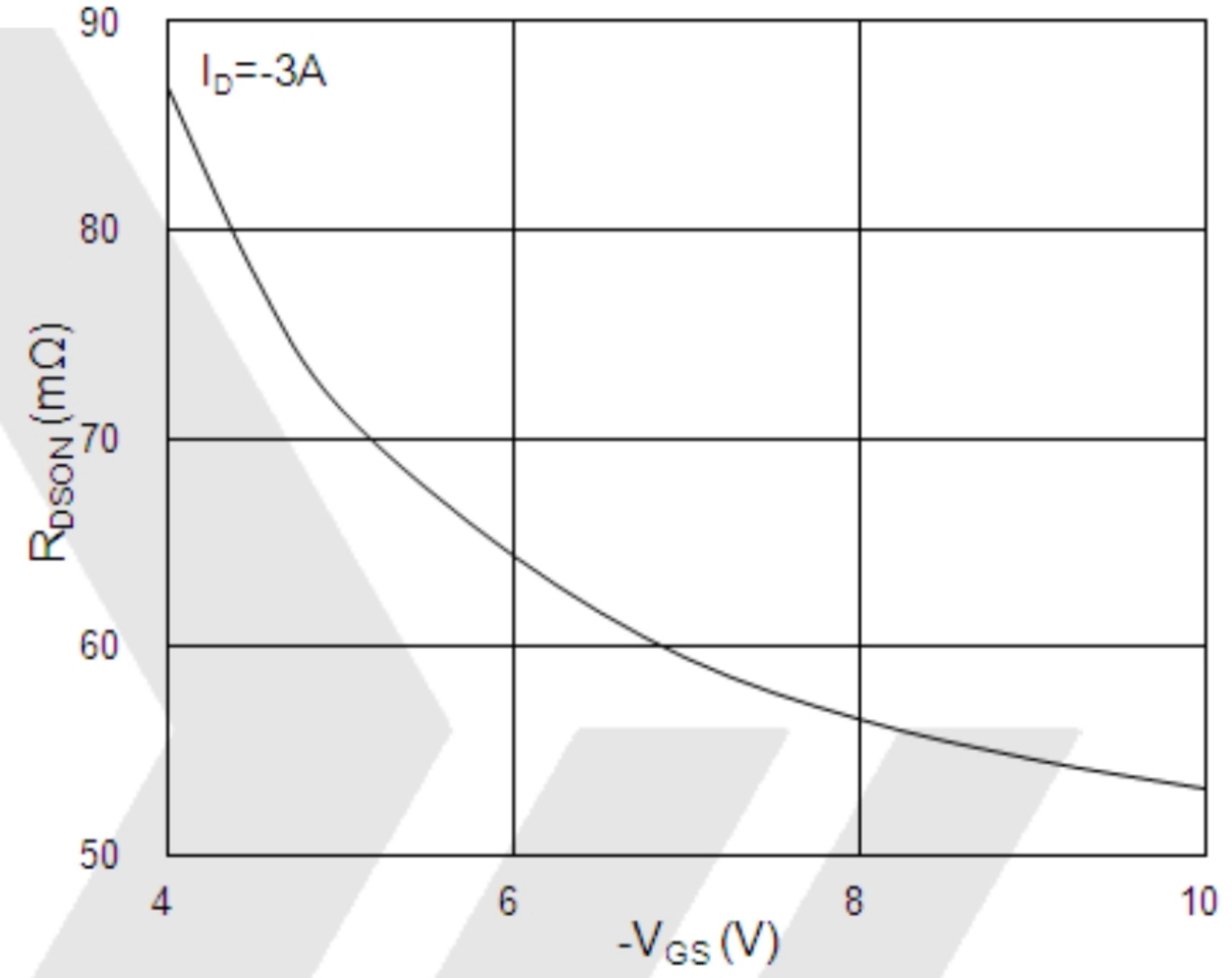
Note 3.The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub> , in real applications , should be limited by total power dissipation



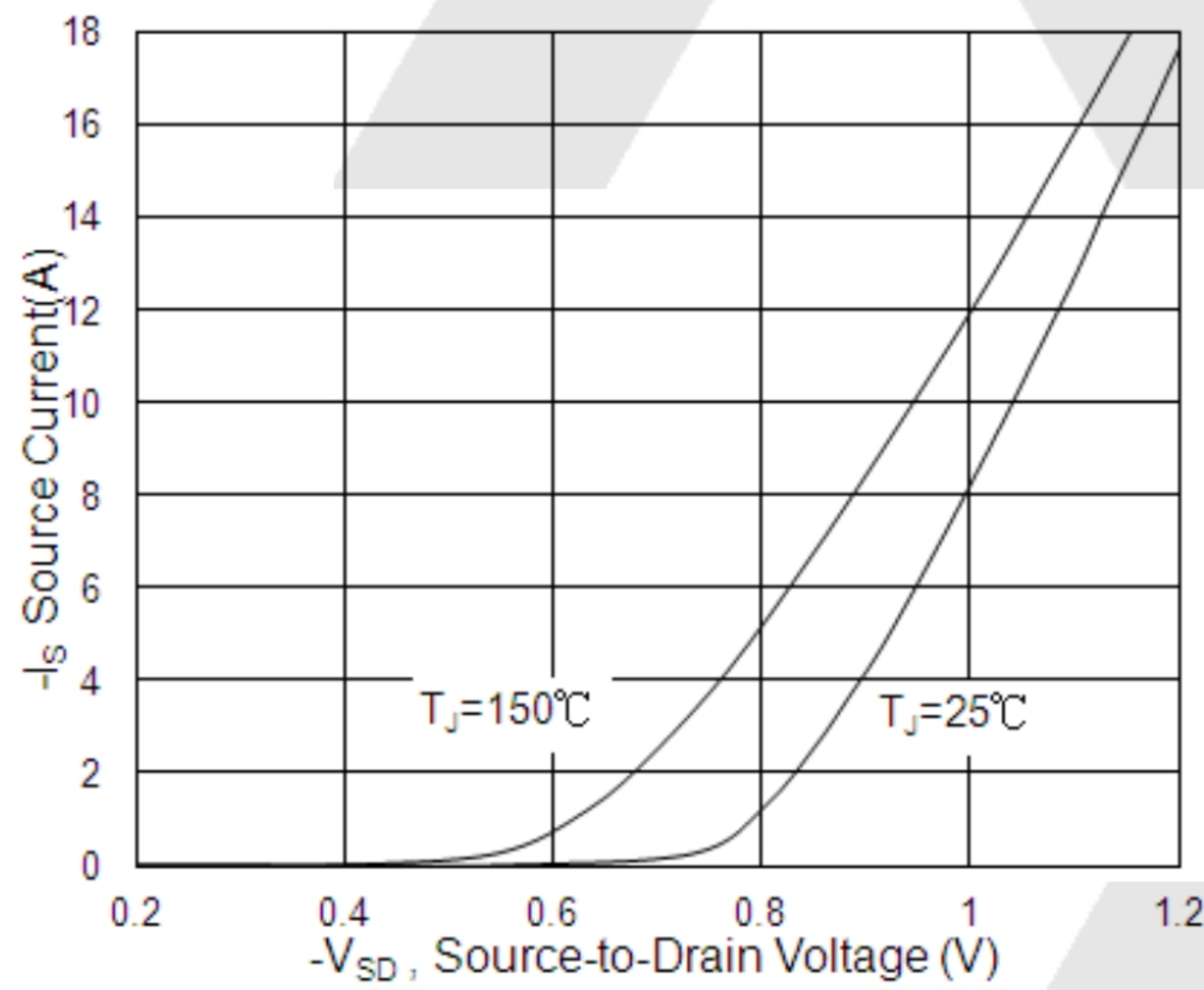
## Thermal Characteristics



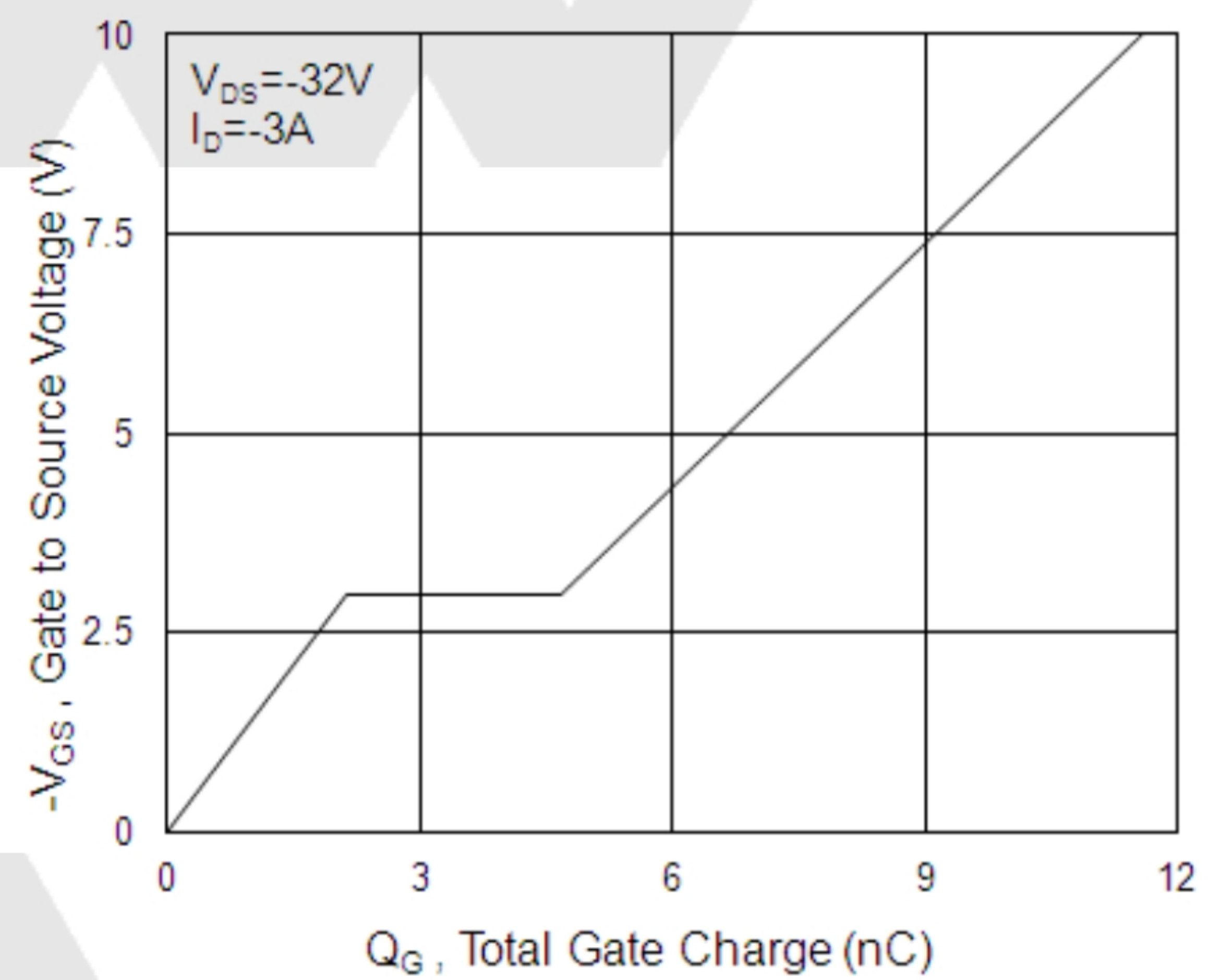
Typical Output Characteristics



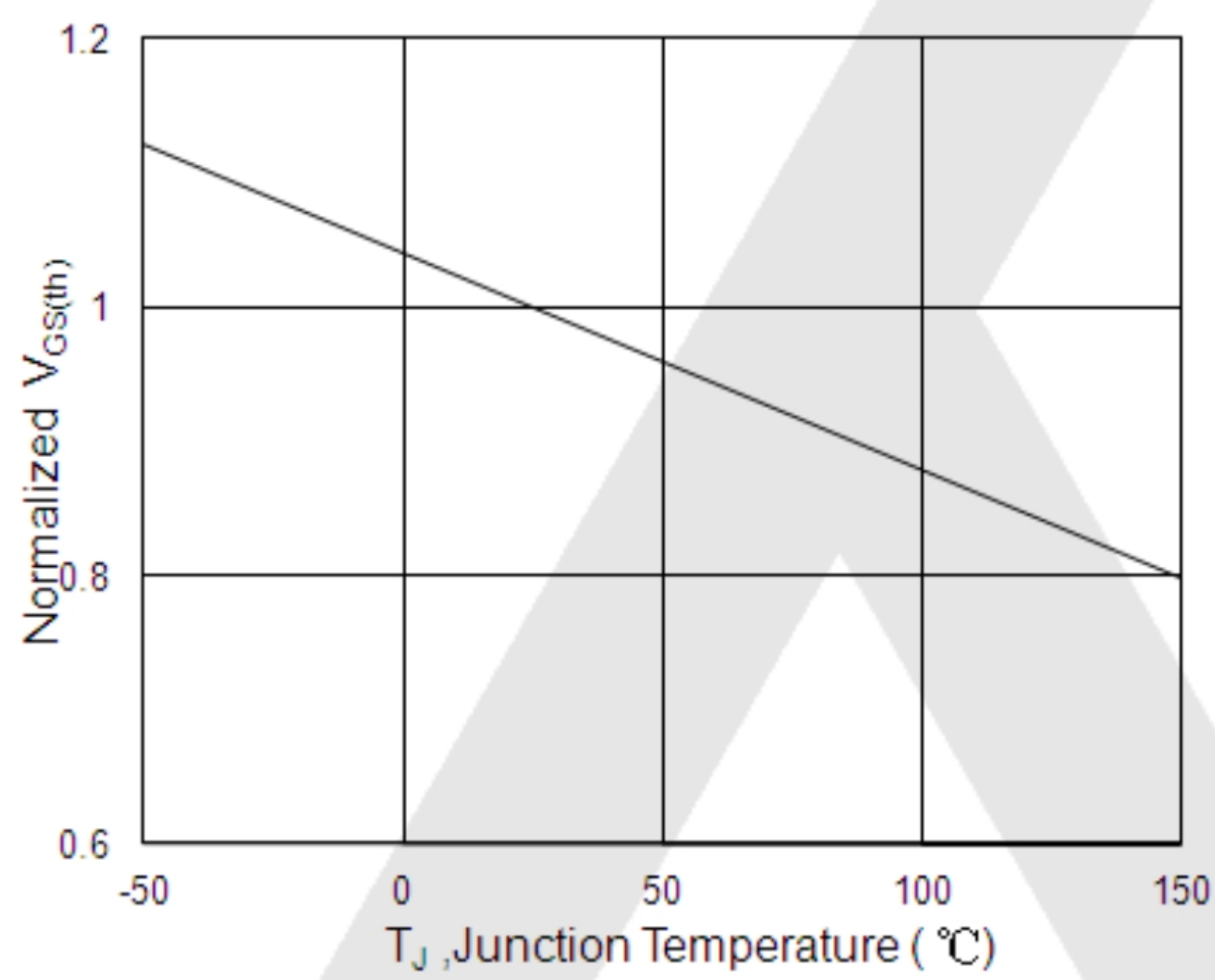
On-Resistance v.s Gate-Source



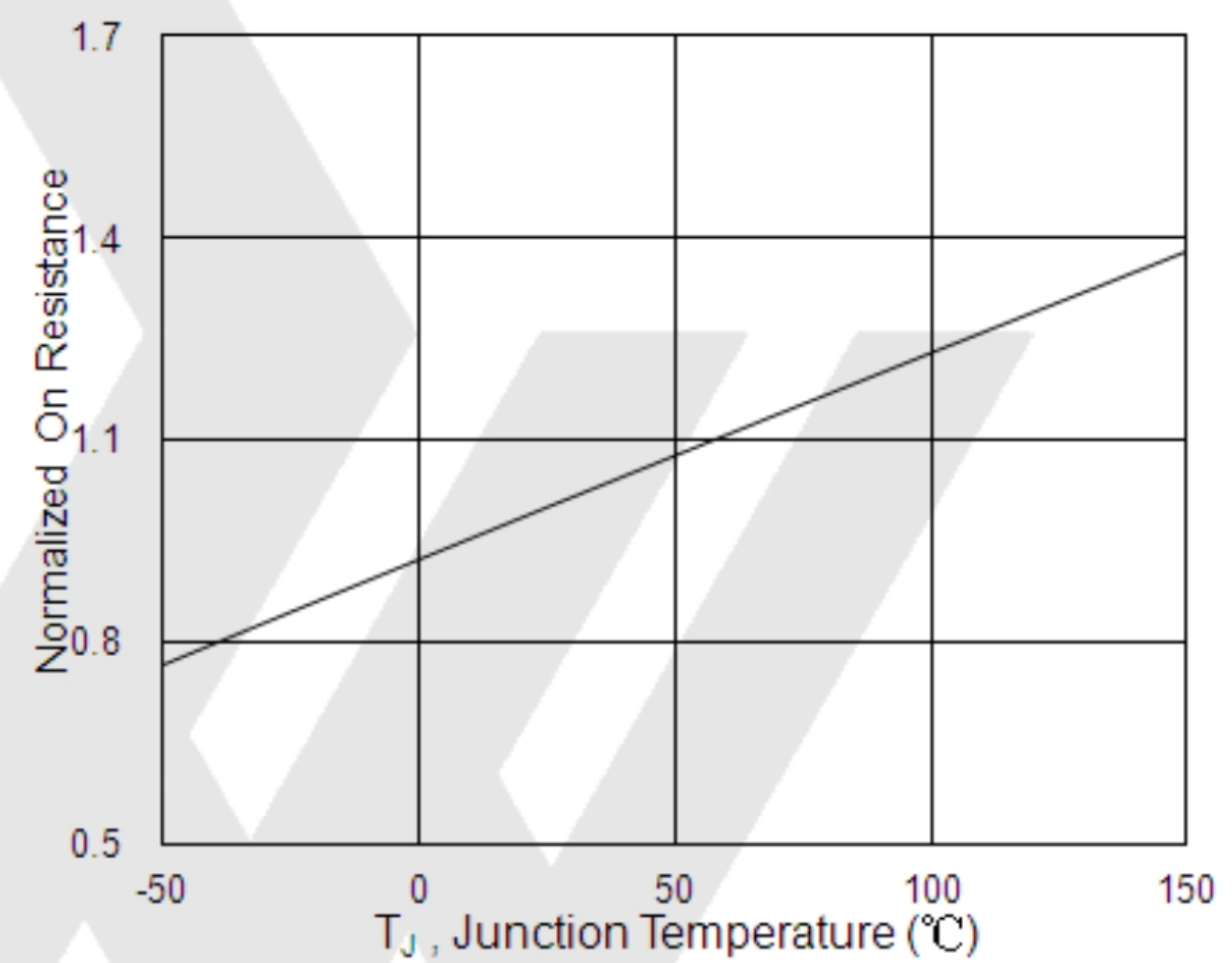
Forward Characteristics Of Reverse



Gate-Charge Characteristics

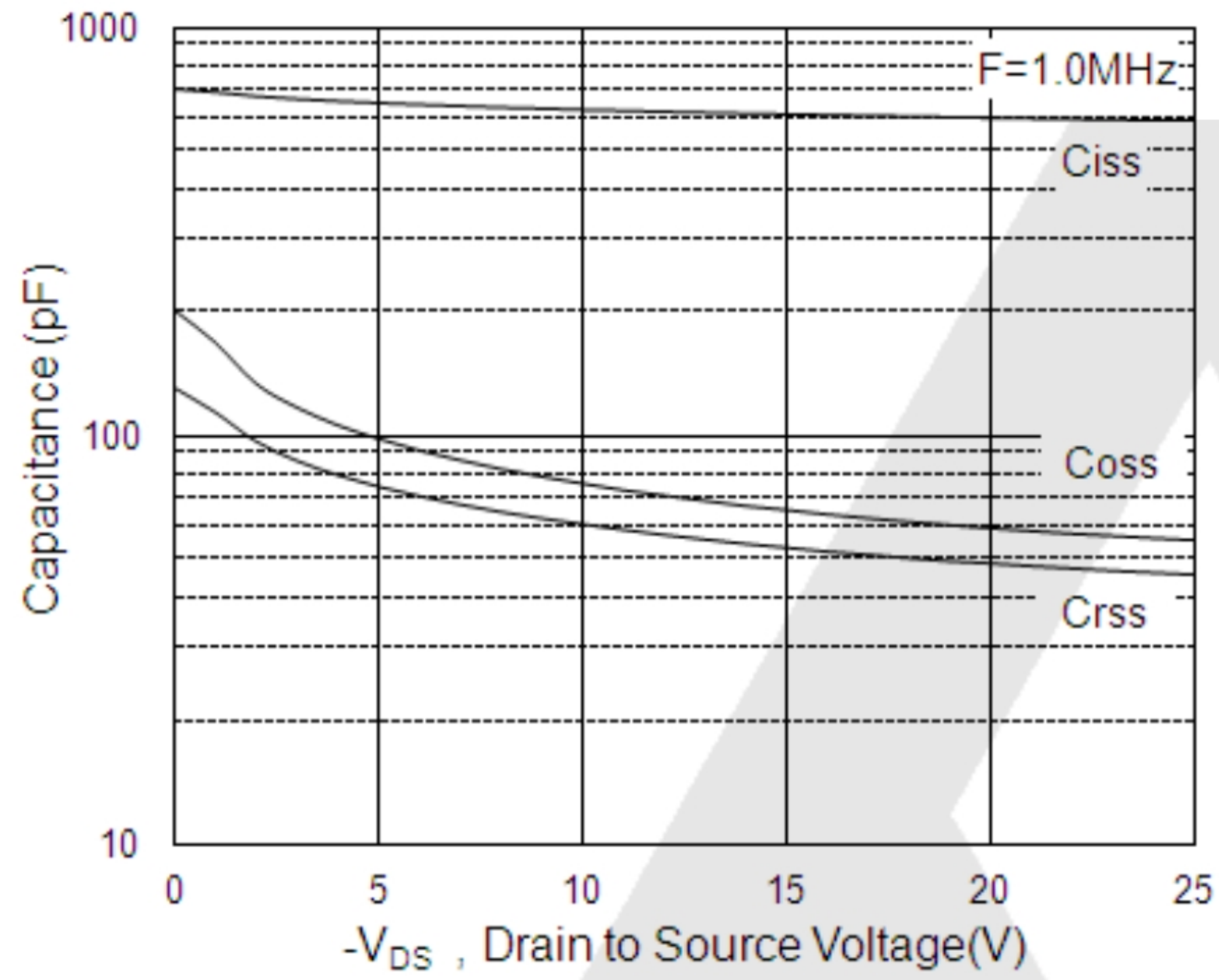


Normalized  $V_{GS(th)}$  v.s  $T_J$

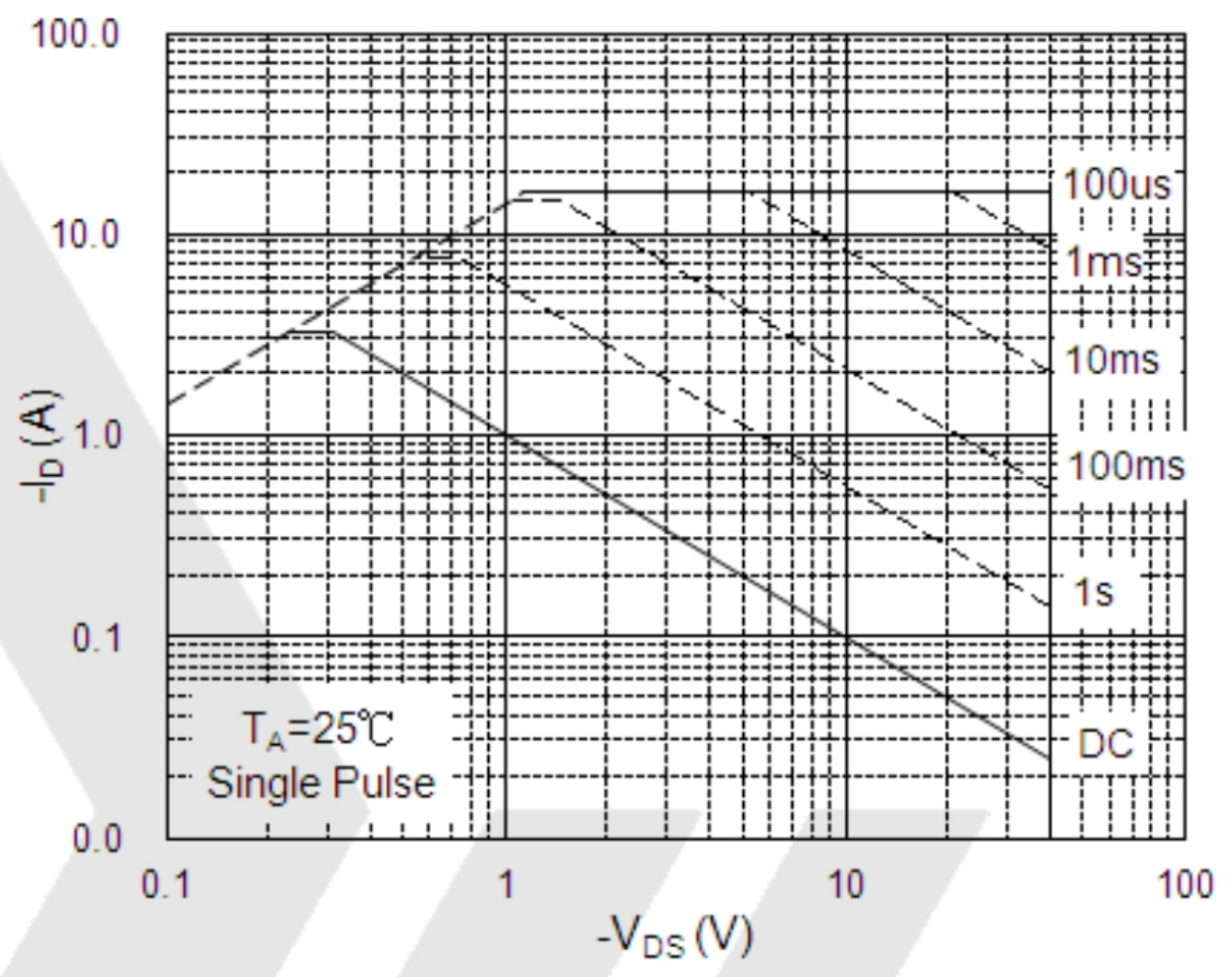


Normalized  $R_{DS(on)}$  v.s  $T_J$

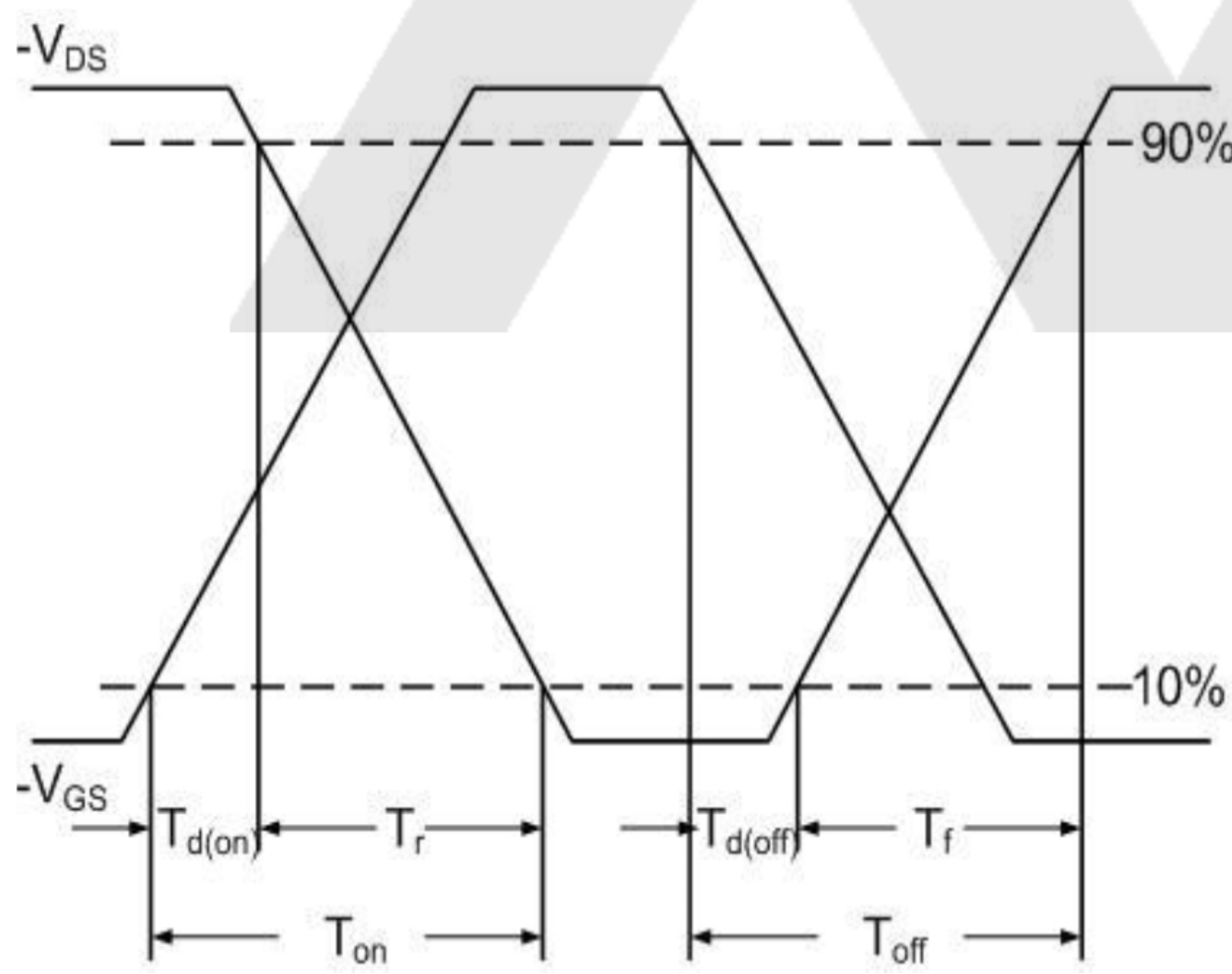




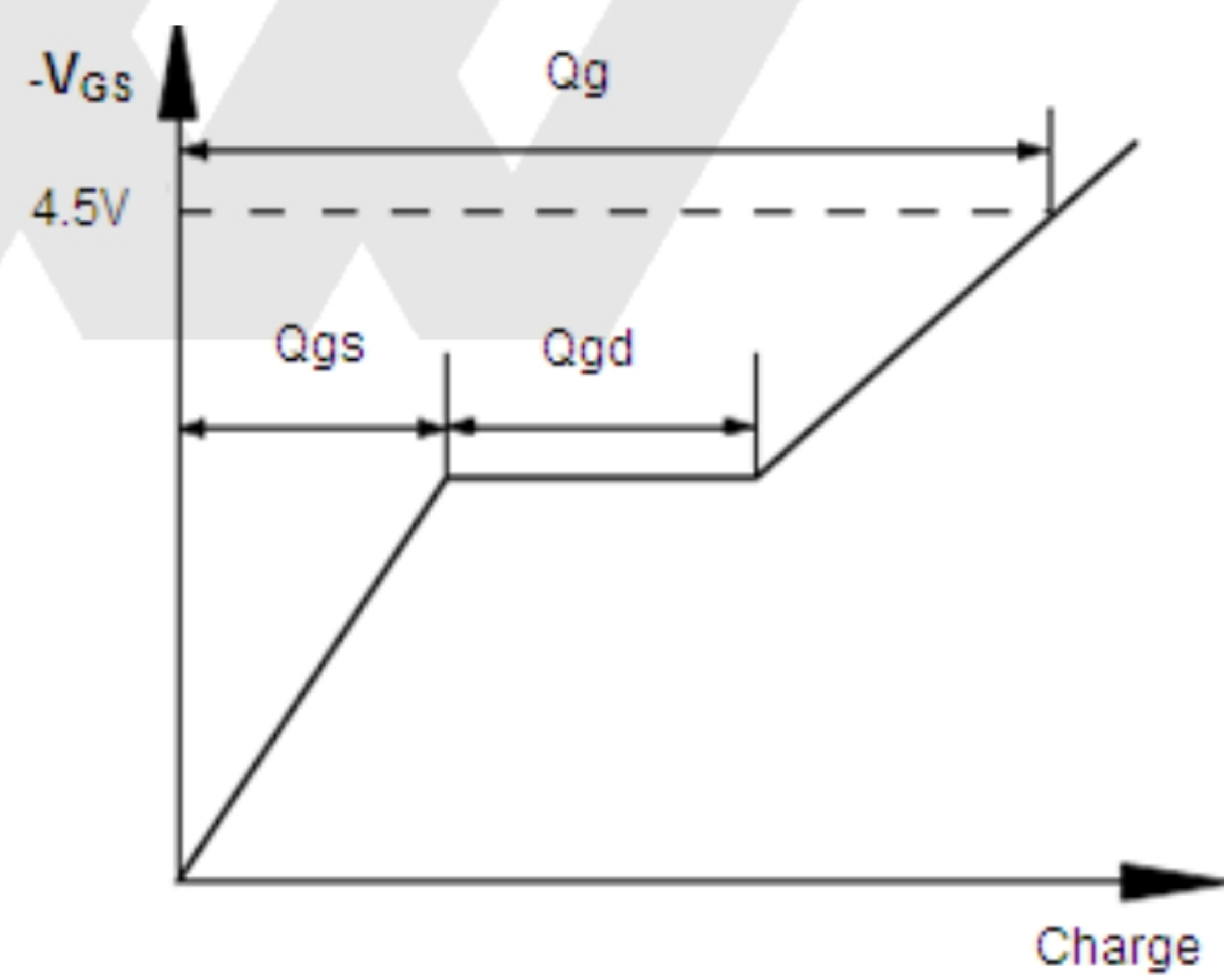
Capacitance



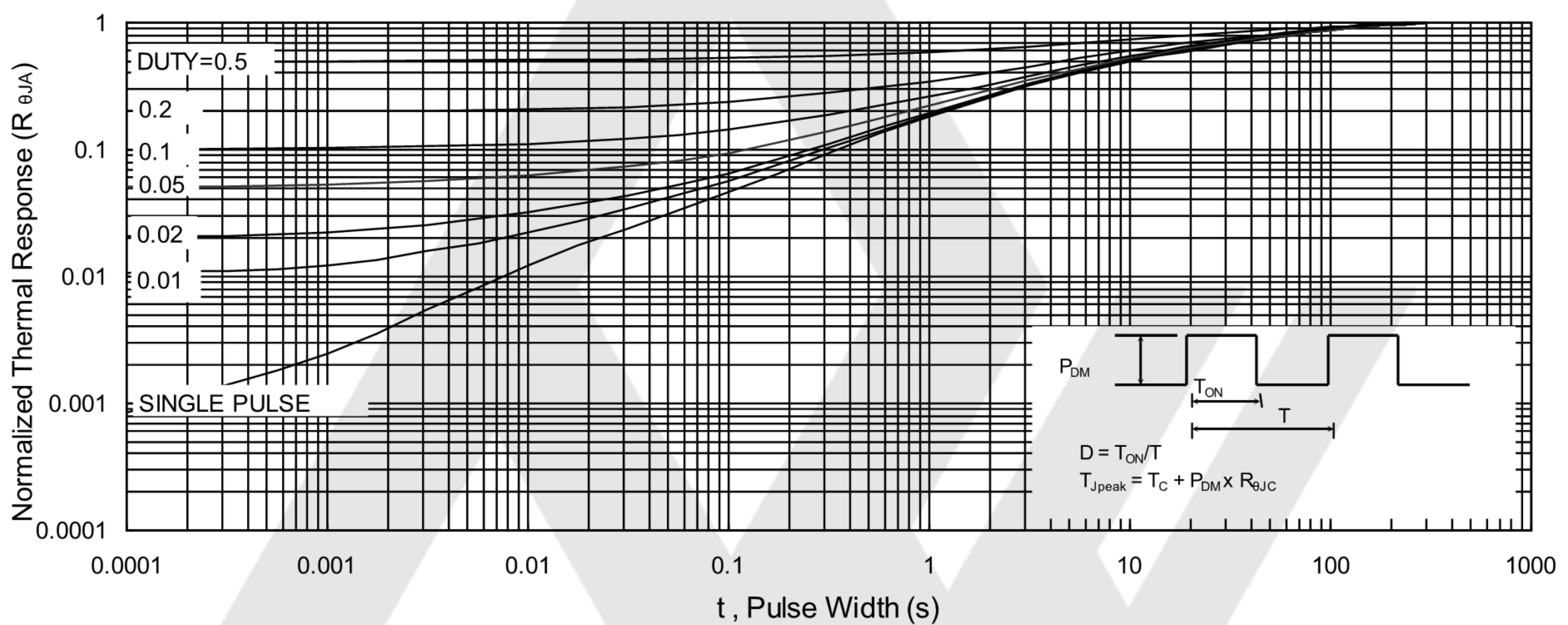
Safe Operating Area



Switching time waveform



Gate Charge waveform

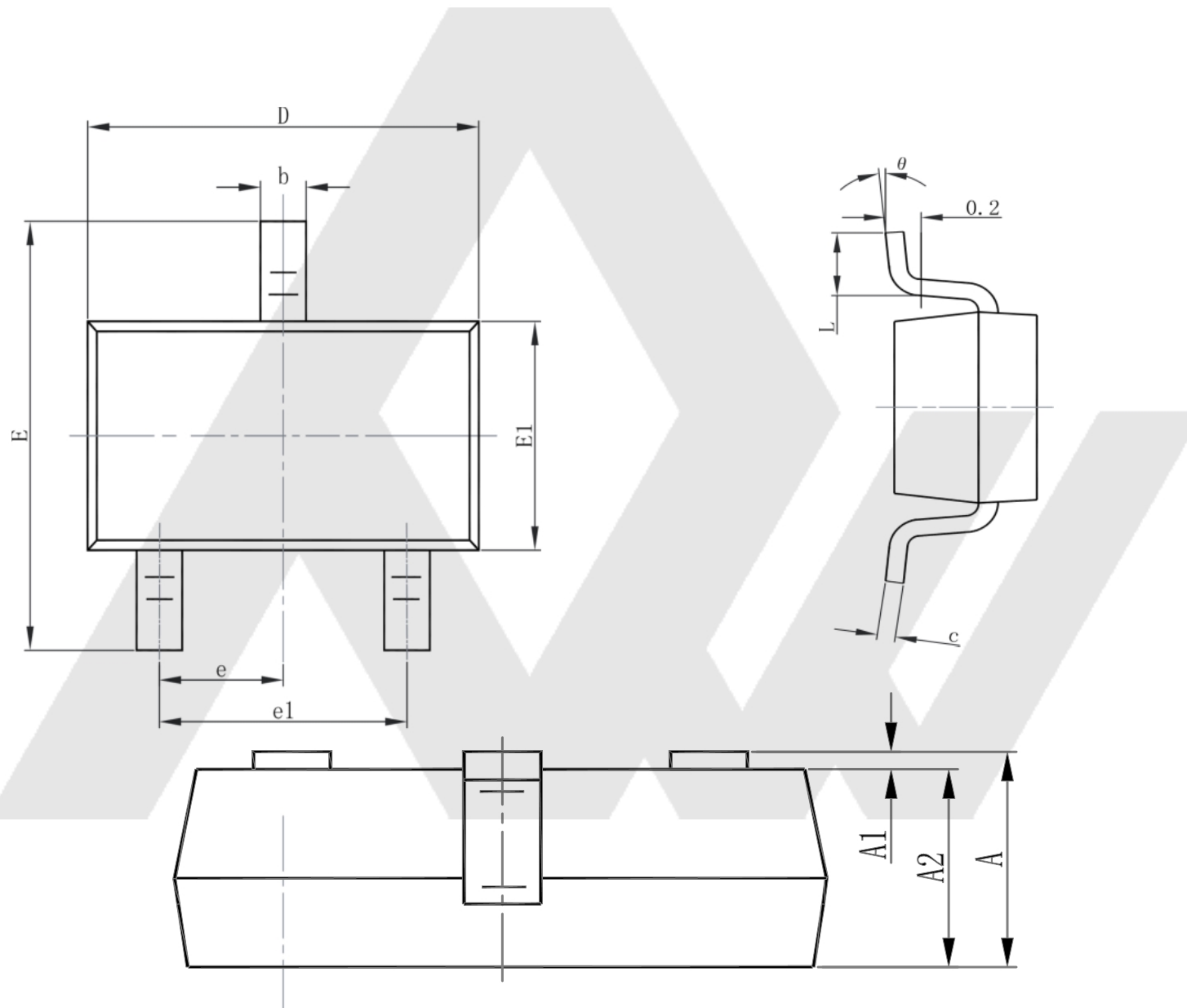


Normalized Maximum Transient Thermal Impedance



## PACKAGE DESCRIPTION

### SOT23-3L



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
c	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
e	0.950(BSC)		0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°

### Notes

1. All dimensions are in millimeters.
2. Tolerance  $\pm 0.10\text{mm}$  (4 mil) unless otherwise specified
3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
4. Dimension L is measured in gauge plane.
5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



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